## Search Notes



| Application/Control I | ю. |
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Reexamination
MATSUDA ET AL.

Applicant(s)/Patent Under

Examiner

Art Unit

EDNA WONG

## SEARCHED

| Class | Subclass | Date    | Examiner |
|-------|----------|---------|----------|
| 205   | 238      | 5/30/03 | EW       |
| 205   | 258      | 5/30/03 | EW       |
| 148   | 240      | 5/30/03 | EW       |
| 205   | 98       | 6/7/06  | EW       |
| 205   | 101      | 6/7/06  | EW       |
| 205   | 318      | 6/7/06  | EW       |

## SEARCH NOTES

| Search Notes        | Date     | Examiner |
|---------------------|----------|----------|
| Inventor Search     | 5/30/03  | EW       |
| WEST                | 5/30/03  | EW       |
| STN                 | 5/30/03  | EW       |
| Search Updated      | 1/10/04  | EW       |
| Search Updated      | 8/20/04  | EW       |
| Search Updated      | 5/3/05   | EW       |
| Search Updated      | 11/21/05 | EW       |
| Search Updated      | 6/7/06   | EW       |
| Search Updated      | 3/26/07  | EW       |
| Search Updated      | 9/22/07  | EW       |
| Search Updated      | 5/26/09  | EW       |
| Search Updated      | 12/29/09 | EW       |
| Search Updated      | 7/7/10   | EW       |
| Interference Search | 7/7/10   | EW       |

## INTERFERENCE SEARCH

| Class | Subclass | Date   | Examiner |
|-------|----------|--------|----------|
| 205   | 238      | 7/7/10 | EW       |
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| 205   | 98       | 7/7/10 | EW       |
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